


Search Notes 	Application/Control No. 10538126	Applicant(s)/Patent Under Reexamination KUROIWA ET AL.
	Examiner Jaisle, Cecilia M	Art Unit 1624

SEARCHED			
Class	Subclass	Date	Examiner
514	248	9/21/2007	Cecilia Jaisle
540	461, 578	9/21/2007	Cecilia Jaisle
544	235, 236	9/21/2007	Cecilia Jaisle

SEARCH NOTES		
Search Notes	Date	Examiner
STN and Inventor Names searched by STIC	9/21/2007	Cecilia Jaisle

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner